Notice of References Cited Application/Control No. 10/553,802 Examiner Art Unit Philip H. Leung 3742 U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination TANAKA ET AL. Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,596,037	07-1971	Seulln et al.	219/676
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